


<b>Search Notes</b>  	<b>Application/Control No.</b>  10565078	<b>Applicant(s)/Patent Under Reexamination</b>  INAGAKI ET AL.
	<b>Examiner</b>  Abul Kalam	<b>Art Unit</b>  2814

SEARCHED			
Class	Subclass	Date	Examiner
257	700	5/7/2010	ak

SEARCH NOTES		
Search Notes	Date	Examiner
See East Search History	5/7/2010	ak
257/e23.067,e23.173,e23.1745	5/7/2010	ak
Interference Search: ((multi\$1layer near2 (substrate or interposer or carrier)) same ((conductive or metal) near2 layer) same (power with ground\$3)).clm.	5/7/2010	ak

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
257	700	5/7/2010	ak

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